

Notic of References Cited	Application/Control N 09/731,593	Applicant(s)/Patent Under R examinati n VOIGT ET AL.	
	Examiner Hal D Wachsman	Art Unit 2857	Pag 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
12-04	*	N DE 195 20 744 C2	09-1989	Germany	Fritz et al. (Abstract only / translated)	—1—
12-04	*	O DE 196 35 233 A1	03-1998	Germany	Kagermeier (Abstract only / translated)	—1—
12-04	*	P DE 30 43 894	12-1989	Germany	Grudowski et al. (Abstract only / translated)	—1—
	*	Q EP 06 04 091 A2	06-1994	Europe	Kokai et al.	—1—
12-04	*	R JP 10254507	09-1998	Japan	Gokan et al. (Abstract only / translated)	—1—
12-04	*	S JP 08106306	04-1996	Japan	Ono (Abstract only / translated)	—1—
12-04	*	T JP11219207 A	08-1999	Japan	Hara (Abstract only / translated)	—1—

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.